Form PTO 1449		U.S. DEPARTMENT OF COMMERCE			ATTY DOCKET NO.		SERIAL NO. 10/602558				
(Modified)			PATENT AND TRAD	EMARK OFFICE	239480US0DIV	New Application					
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\vdash			5,549,952		ARAI, ET AL.	 \ 	 \ 				
	 	AC	5,920,329	07/06/99		 					
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	-	AE	5,470,691	11/28/95	ARAI, ET AL.		- 				
		AF	5,616,450	04/01/97	ARAI, ET AL.						
	 	AG	5,705,247	01/06/98	ARAI, ET AL.	 	\Box				
		AH	5,972,457	10/26/99	MATSUISHI, ET AL.	1	-1				
		Al	5,970,027	10/19/99	NARITA, ET AL.		\longrightarrow				
		AJ	4,920,006	04/90	GILLERY						
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		AL	5,138,604	08/92	UMEDA, ET AL.						
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		AR	6,319,581	11/01	TÁMURA	1					
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13	_	AT	6,437,017	08/02	KOMAKI						
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